

MOSFET – Power, Single, P-Channel

-40 V, 13.8 mΩ, -49 A

NVTFS014P04M8L

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS014P04M8L Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR–Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	Drain-to-Source Voltage			-40	V
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	-49	Α
Current R _{θJC} (Notes 1, 2, 4)	Steady	T _C = 100°C		-35	
Power Dissipation	State	T _C = 25°C	P_{D}	61	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		30	
Continuous Drain Current R _{e.IA}		T _A = 25°C	I _D	-11.3	Α
(Notes 1, 3, 4)	Steady	T _A = 100°C		-8	
Power Dissipation	State	T _A = 25°C	P_{D}	3.2	W
R _{θJA} (Notes 1, 3)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_A = 25^\circ$	°C, t _p = 10 μs	I _{DM}	224	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	-50	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = -6.1 A)			E _{AS}	143	mJ
Lead Temperature for S (1/8" from case for 10 s)		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

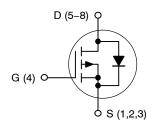
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain) (Notes 1, 2, 4)	$R_{\theta JC}$	2.5	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	47	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
40.\/	13.8 m Ω @ –10 V	_49 A	
–40 V	18.7 mΩ @ -4.5 V	-49 A	

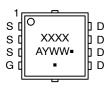
P-Channel MOSFET



MARKING DIAGRAMS



WDFN8 (μ8FL) CASE 511AB





WDFNW8 (Full-Cut m8FL WF) CASE 515AN



XXXX = Specific Device Code A = Assembly Location

Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

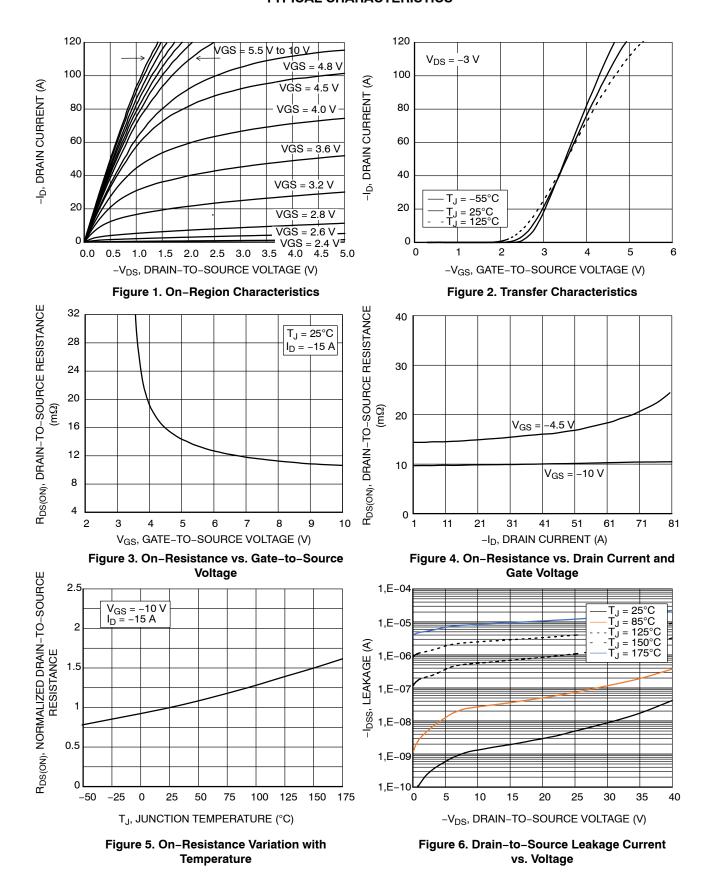
Parameter	Symbol	Test Cond	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				21		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			-1.0	μΑ
		$V_{DS} = -40 \text{ V}$	T _J = 125°C			-1000	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	s = ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)	•						•
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= -420 μA	-1.0		-2.4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.1		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = −10 V, I	_D = -15 A		10	13.8	mΩ
		V _{GS} = -4.5 V, I	_D = -7.5 A		14.6	18.7	1
Forward Transconductance	9 _{FS}	$V_{DS} = -1.5 V,$	_D = -15 A		42		S
CHARGES AND CAPACITANCES							ı
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -20 \text{ V}$			1734		pF
Output Capacitance	C _{oss}				682		1
Reverse Transfer Capacitance	C _{rss}				32		1
Total Gate Charge	Q _{G(TOT)}	VDS = -20 V,	V _{GS} = -4.5V		12.5		nC
	, ,		V _{GS} = -10V		26.5		1
Threshold Gate Charge	Q _{G(TH)}				2.6		nC
Gate-to-Source Charge	Q_{GS}	Vos = -10 V V	ne = -20 V		5.6		1
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = -10 \text{ V}, \text{ V}_{I}$ $I_{D} = -36$	DA		3.8		1
Plateau Voltage	V_{GP}				3.2		V
SWITCHING CHARACTERISTICS, VG	s = -4.5 V (Note	6)					ı
Turn-On Delay Time	t _{d(on)}				11.5		ns
Rise Time	t _r	V _{GS} = -4.5 V, V _I	ne = -20 V.		97.4		
Turn-Off Delay Time	t _{d(off)}	$I_{D} = -30 \text{ A}, R_{0}$	$_{\rm G} = 2.5 \Omega$		44.5		
Fall Time	t _f				38.2		
DRAIN-SOURCE DIODE CHARACTEI	RISTICS						•
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		-0.86	-1.25	V
		$I_{S} = -15 A$	T _J = 125°C		-0.74		1
Reverse Recovery Time	t _{RR}		•		34.9		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt}$:= 100 A/us.		15.8		1
Discharge Time	t _b	$I_{S} = -10$	Α Α		19.1		1
Reverse Recovery Charge	Q _{RR}	1			16.3	52	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (continued)

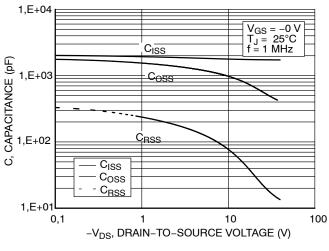
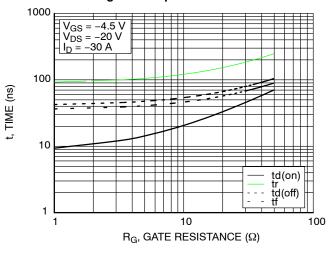


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge



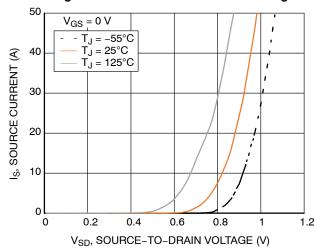
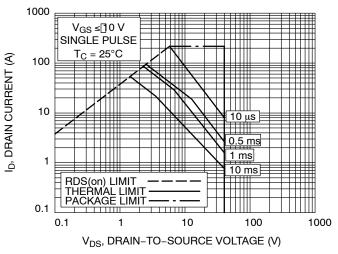


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



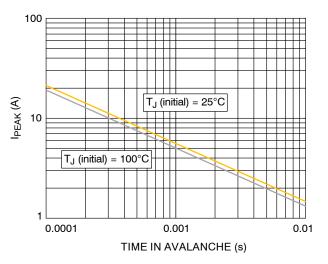


Figure 11. Maximum Rated Forward Biased Dafe operating Area

Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS (continued)

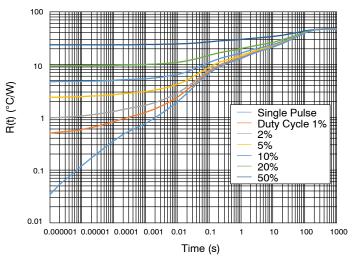


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS014P04M8LTAG	014M	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS014P04M8LTAG	014W	WDFNW8 (Pb-Free, Wettable Flank)	1500 / Tape & Reel

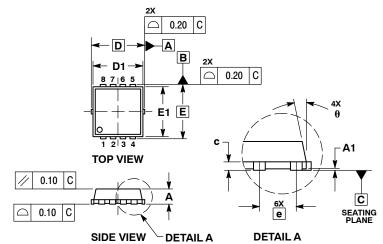
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

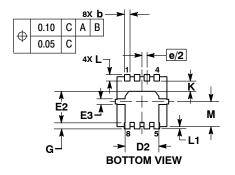
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MI	MILLIMETERS			INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC	;
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			(0.026 BS	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

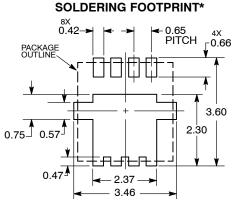


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

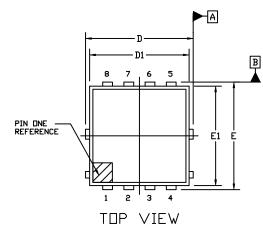
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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1	

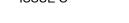
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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.



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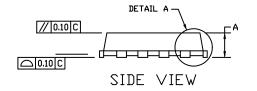


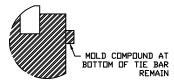
NDTES:

- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 D0 NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

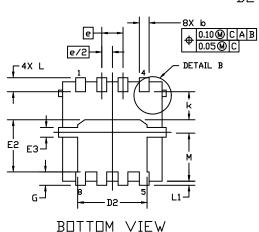
	PLATED AREA
DETAIL	C C SEATING PLANE

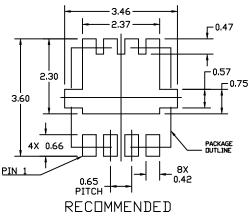
	MILLIMETERS		
DIM	MIN.	NDM.	MAX.
A	0.70	0.75	0.80
A1	0.00		0.05
ø	0.23	0.30	0.40
n	0.15	0.20	0.25
D	3.05	3.30	3.55
D1	2.95	3.05	3.15
D2	1.98	2.11	2.24
Ε	3.05	3.30	3.55
E1	2.95	3.05	3.15
E2	1.47	1.60	1.73
E3	0.23	0.30	0.40
a		0.65 BSC	
G	0.30	0.41	0.51
K	0.65	0.80	0.95
٦	0.30	0.43	0.59
L1	0.06	0.13	0.20
М	1.40	1.50	1.60





DETAIL B





MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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